

### **Integrated Current Sensor GXL AN series**

### **Description**

GXL AN is a 200A range Integrated Current Sensor (ICS) built with QFN package technology, providing an excellent power density for power PCB current measurements with built in galvanic insulation. This product is a high precision integrated current sensor (ICS) from LEM, where the current goes through its primary pins and does not require a core (coreless product).

The GXL product family provides a very accurate solution for measuring DC and AC currents in all highly compact and demanding industrial and automotive applications. This product uses a very small QFN package technology with large primary pads and wettable flanks for soldering and visual inspection. It provides analog voltage output with best-in-class accuracy together with overcurrent detections (user configurable and factory set).

The current goes through the primary pins (1 to 8) which have a very low internal resistance (<0.25 mΩ). The secondary pins have 6mm distance creepage / clearance from the primary in order to insure a good enough isolation level.

These features make the device suitable for high voltage applications requiring high precision and strong immunity against external field with its differential sensing solution.

#### Main features & Advantages

- Industrial and automotive
- Open loop multi-range current sensor: 200A
- Low electrical resistance  $< 0.25 \text{m}\Omega$
- Dual supply voltage 5V and 3.3V
- User settable fast overcurrent detection
- Low power consumption
- Compact design for surface mount PCB mounting
- High bandwidth
- Galvanic separation between primary and secondary with 6 mm of dCp/dCl
- Reinforced insulation capability



#### Typical applications

- **Drives**
- **HVAC Inverters**
- **Appliances**
- Solar Inverters
- **Automotive**

#### **Standards**

- IEC 61800-5-1: 2007
- IEC 62109-1: 2010
- IEC 62368-1: 2018 (replacing IEC 60950-1)
- **UL 1577: 2014 (Pending)**
- **UL 62638-1 (Pending)**
- AEC-Q-100 Grade 0 qualified (pending)



Figure 1: GXL QFN package



### **Pinout**

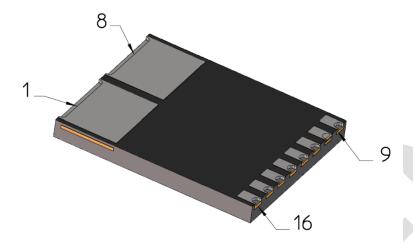


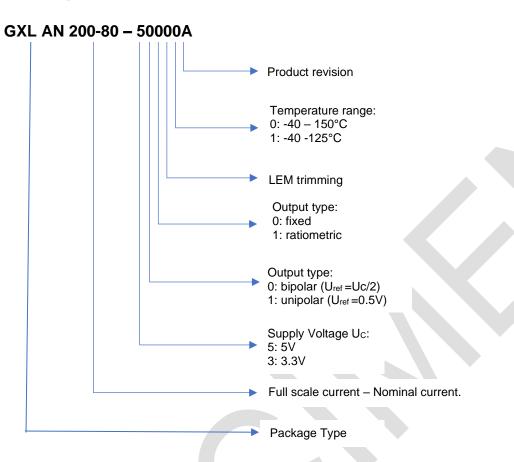
Figure 2: GXL package with pin number (bottom view)

Pin#	Name	Туре	Description
1	lp+	Input	input (+) of the primary current
8	I <sub>P</sub> -	Input	Input (-) of the primary current
9	Uc	Power	Supply voltage
10	UE ocd	Input	External OCD threshold voltage terminal
11	OCD INT	Output	Internal OCD
12	Uout	Output	Output voltage
13	Uref	Output	Reference voltage
14	NC	N/A	Connect to GND
15	OCD EXT	Output	External OCD terminal
16	GND	Ground	Ground terminal

Table 1: GXL AN Device Pin Function Description.



## **Selection guide**



#### **Standard products**

Product name	Full scale range (A peak)	Nominal current (A rms) <sup>1</sup>	Sensitivity (mV/A)	Supply Voltage (V)	Polarity	Output type
GXL AN 125-50 50000B	± 125	±50	16	5 V	Bipolar	Fixed
GXL AN 200-80 50000B	± 200	±80	10	5 V	Bipolar	Fixed
GXL AN 125-50 30000B	± 125	±50	10	3.3 V	Bipolar	Fixed
GXL AN 200-80 30000B	± 200	±80	6.25	3.3 V	Bipolar	Fixed
GXL AN 125-50 50100B	± 125	±50	16	5 V	Bipolar	Ratiometric
GXL AN 200-80 50100B	± 200	±80	10	5 V	Bipolar	Ratiometric
GXL AN 125-50 30100B	± 125	±50	10	3.3 V	Bipolar	Ratiometric
GXL AN 200-80 30100B	± 200	±80	6.25	3.3 V	Bipolar	Ratiometric

Table 2

<sup>&</sup>lt;sup>1</sup> Trimmings at LEM are done at this nominal current



# **Block diagram**

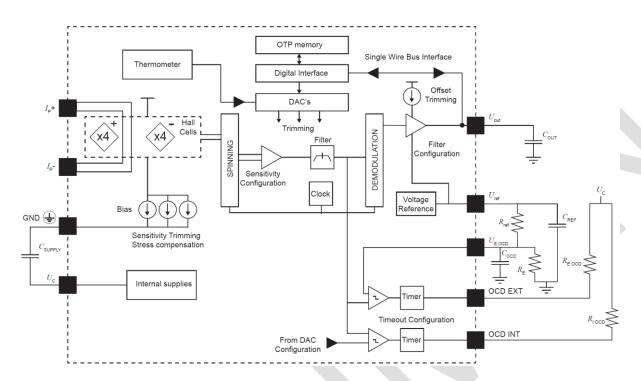


Figure 3 Block diagram GXL AN

External circuit example	Min	Тур	Max	Unit
R <sub>ref</sub>	4.7	47		kΩ
Re	4.7	47		kΩ
R <sub>e_ocd</sub>	1	4.7	50	kΩ
R <sub>i_ocd</sub>	1	4.7	50	kΩ
Cout	_	4.7	6	nF
C <sub>supply</sub>	10	47		nF
Cref	-	4.7	47	nF
Cout		4.7		nF

Table 3: Specification Table of External Component Values



# **Absolute maximum ratings**

Parameter	Symbol	Unit	Value
Maximum supply voltage	U <sub>C max</sub>	V	7.5
Maximum voltage on other pins	U <sub>max</sub>	V	7.5
Electrostatic discharge voltage (HBM - Human Body Model)	<b>U</b> ESD HBM	kV	2
Electrostatic discharge voltage (CDM - Charged Device Model)	U <sub>ESD</sub> CDM	V	500
Maximum junction temperature	T <sub>J max</sub>	°C	165

Table 4

Absolute maximum ratings apply at 25 °C unless otherwise noted.

Stresses above these ratings may cause permanent damage.

Exposure to absolute maximum ratings for extended periods may degrade reliability.

### **Environmental and mechanical characteristics**

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Ambient operating temperature	$T_A$	°C	-40		150	
Ambient storage temperature	T <sub>A st</sub>	°C	-55		165	
Thermal resistance junction to case <sup>2</sup>	R <sub>th</sub> JC	K/W		18		
Thermal resistance junction to ambient <sup>2</sup>	R <sub>th</sub> JA	K/W		19		
Mass	m	g		1.4		

Table 5

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<sup>&</sup>lt;sup>3</sup> 100% tested in production.



### **Insulation characteristics GXL**

Parameter	Symbol	Unit	Value	Comment
RMS voltage for AC insulation test, 50Hz, 1min	Ud	kV	4.53 <sup>3</sup>	According to IEC 62368-1
Impulse withstand voltage 1.2/50 μs	U <sub>NI</sub>	kV	6.40	According to IEC 62109-1, IEC 61800-5-1
RMS recurring peak voltage (Partial discharge test)	U <sub>PD</sub>	V	933	According to IEC 62109-1, IEC 61800-5-1
RMS inception voltage (Partial discharge test)	U <sub>t inception</sub>	V	1238	According to IEC 62109-1, IEC 61800-5-1
RMS extinction voltage (Partial discharge test)	Ut extinction	V	990	According to IEC 62109-1, IEC 61800-5-1
Clearance (prisec.)	<b>d</b> <sub>Cl</sub>	mm	6	Shortest distance through air
Creepage distance (prisec.)	<b>d</b> Cp	mm	6	Shortest path along device body
Case material			V0	According to UL94, flammability
Comparative tracking index	СТІ		600	Grade requirements mass compound

Table 6

### Working voltage according to IEC 62368-1

Working voltage		PD 2	Standards	
Basic insulation	RMS voltage (V)	1192	IEC 62368-1	
Reinforced insulation	RMS voltage (V)	593	(replacing IEC 60950-1)	

Table 7

### Rated insulation voltage according to IEC 61800-5-1

Rated insulation voltage		OV II / PD 2	OV III/ PD 2	Standards
Basic isolation	RMS voltage (V)	1104	600	IEC 61800-5-1
Reinforced isolation	RMS voltage (V)	593	300	

Table 8

### Rated insulation voltage according to IEC 62109-1

Rated insulation voltage		OV II / PD 2	OV III/ PD 2	Standards	
Basic isolation	RMS voltage (V)	> 1000	600	IEC 62109-1	
Reinforced isolation	RMS voltage (V)	593	300		

Table 9

<sup>&</sup>lt;sup>3</sup> Tested at 4.07 kV in production.



# Common electrical data (independent of sensitivity) At $T_A = 35$ °C, $U_C = +5$ V, $R_L = 100$ k $\Omega$ , unless otherwise noted

### Supply characteristics and consumption

Parameter	Symbol	Unit	Min	Тур	Max	Comment
DC supply voltage	<b>U</b> c	V	4.5	5	5.5	5V versions
DC supply voltage	Uc	V	3.135	3.3	3.465	3V3 versions
DC Current consumption	lc	mA		20	26	
Start-up time	T <sub>start</sub>	ms		3		

Table 10

### **Primary characteristics**

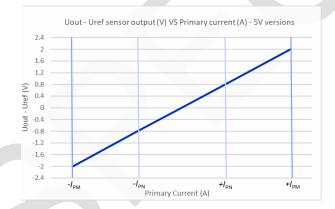
Parameter	Symbol	Unit	Min	Тур	Max	Comment
Resistance of the primary	$R_P$	mΩ		<0.25		$T_A = 25  ^{\circ}C$

Table 11

### **Output characteristics**

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Output voltage range	U <sub>out</sub> -U <sub>ref</sub>	٧	-2		2	5V versions U <sub>C≥</sub> 4.6 V , @ <i>I</i> <sub>PM</sub>
Output voltage range	Uout-Uref	V	-1.25		1.25	3V3 versions @ I <sub>PM</sub>
Output internal resistance of Uout	Rout	Ω		1		·
Maximum output current source of Uout	I <sub>Omax</sub>	mA	20			
Maximum input current sink of Uout	I <sub>lmax</sub>	mA	20			
Load capacitance on Uout	$C_L$	nF	0	4.7	6	
Delay time (input slope= lpn	<i>t</i> <sub>D10</sub>	μS		1		@ 10 % of I <sub>PN</sub>
(20A/µs))	<i>t</i> <sub>D90</sub>	μS		1.6		@ 90 % of IPN
Frequency bandwidth	BW	kHz		300		@ -3dB

Table 12



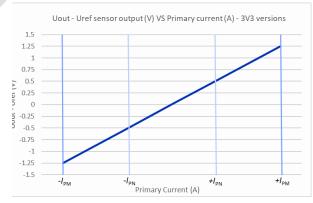


Figure 3 & 4: Sensor output voltage referred to Uref.



#### Internal reference characteristics

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Internal reference voltage @ IP = 0 A	Ulref	V	2.48	2.5	2.52	5V versions
Internal reference voltage @ IP = 0 A	Uout-Uref	V	1.64	1.65	1.66	3V3 versions
Temperature coefficient of U <sub>ref</sub>	TCU <sub>ref</sub>	ppm/K	-220	±75	220	−40 °C 150 °C
Output internal resistance of Uref	Rref	Ω		5		
Maximum output current source of Uref	I <sub>Omax</sub>	mA		0.5	1	
Maximum input current sink of Uref	I <sub>lmax</sub>	mA		0.5	1	
Load capacitance on Uref	$C_L$	nF	0	4.7	47	

Table 13

#### **Lifetime parameters**

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Sensitivity error drift after ageing	<b>E</b> s	%		TBD		TBC based on characterization after qualification.
Offset drift after ageing	U <sub>OE</sub>	mV		TBD		TBC based on characterization after qualification.
Total accuracy over temp	<b>€</b> tot	%		TBD		TBC based on characterization after qualification.
Total accuracy over lifetime	<b>€</b> tot	%		TBD		TBC based on characterization after qualification.

Table 14



### Electrical data GXL AN 125-50 50000B

At  $T_A$  = 25 °C,  $U_C$  = +5 V,  $R_L$  = 100 k $\Omega$ , unless otherwise noted

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary nominal current	<i>I</i> <sub>PN</sub>	Α		50		
Primary current, measuring range	I <sub>PM</sub>	Α	-125		125	
Nominal sensitivity	SN	mV/A		16		800 mV @ I <sub>PN</sub>
Sensitivity error @35°C	<b>&amp;</b> S	%	-0.5		0.5	TBC
Sensitivity error @35°C-150°C	<b>E</b> SHOT	%	-2.1		2.1	From 35°C to 150°C - TBC
Sensitivity error @-40°C-35°C	<b>E</b> SCOLD	%	-2.3		2.3	From -40°C to 35°C - TBC
Sum of sensitivity and linearity error	<b>€</b> SL25	% of <i>I</i> <sub>PM</sub>	-0.7		0.7	@35°C TBC
Electrical offset voltage	UOE	mV	-5		5	U <sub>out</sub> -U <sub>Iref</sub> @ U <sub>Iref</sub> =2.5 V
Electrical offset error @35°C-150°C	<b>U</b> оЕНОТ	mV	-7	4	7	U <sub>out</sub> -U <sub>ref</sub>
Electrical offset error @-40°C-35°C	UOECOLD	mV	-6.5		6.5	Uout-Uref
Noise voltage spectral density	Uno	μV/Hz <sup>1/2</sup>				TBC
Linearity error 0 ±IPN	<b>E</b> ∟	%	-0.5		0.5	Referred to IPN
Linearity error 0 ±IP M	<b>E</b> ∟	%	-0.5		0.5	Referred to IPM
Total error at I <sub>PM</sub>	<b>€</b> tot	% of I <sub>PM</sub>	-2.4		2.4	From -40°C to 150°C

Table 15

#### Electrical data GXL AN 200-80 50000B

At  $T_A = 25$  °C,  $U_C = +5$  V,  $R_L = 100$  k $\Omega$ , unless otherwise noted

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary nominal current	<i>l</i> PN	Α		80		
Primary current, measuring range	<b>/</b> PM	A	-200		200	
Nominal sensitivity	SN	mV/A		10		800 mV @ I <sub>P N</sub>
Sensitivity error @35°C	<b>E</b> s	%	-0.5		0.5	TBC
Sensitivity error @35°C-150°C	<b>E</b> SHOT	%	-2.1		2.1	From 35°C to 150°C - TBC
Sensitivity error @-40°C-35°C	<b>E</b> SCOLD	%	-2.3		2.3	From -40°C to 35°C - TBC
Sum of sensitivity and linearity error	<b>E</b> SL25	% of I <sub>PM</sub>	-0.7		0.7	@35°C TBC
Electrical offset voltage	UoE	mV	-5		5	U <sub>out</sub> -U <sub>Iref</sub> @ U <sub>Iref</sub> =2.5 V
Electrical offset error @35°C-150°C	<b>U</b> оЕНОТ	mV	-7		7	U <sub>out</sub> -U <sub>ref</sub>
Electrical offset error @-40°C-35°C	UOECOLD	mV	-6.5		6.5	Uout-Uref
Noise voltage spectral density	Uno	μV/Hz <sup>1/2</sup>				TBC
Linearity error 0 ±IPN	EL	%	-0.5		0.5	Referred to IPN
Linearity error 0 ±IPM	<b>£</b> ∟	%	-0.5		0.5	Referred to IPM
Total error at IPM	<b>€</b> tot	% of <i>I</i> РМ	-2.4		2.4	From -40°C to 150°C

Table 16

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#### Electrical data GXL AN 125-50 30000B

At  $T_A$  = 25 °C,  $U_C$  = +3.3 V,  $R_L$  = 100 k $\Omega$ , unless otherwise noted

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary nominal current	<i>I</i> PN	Α		50		
Primary current, measuring range	I <sub>PM</sub>	Α	-125		125	
Nominal sensitivity	SN	mV/A		10		500 mV @ I <sub>PN</sub>
Sensitivity error @35°C	<b>&amp;</b> s	%	-0.5		0.5	TBC
Sensitivity error @35°C-150°C	<b>E</b> SHOT	%	-2.1		2.1	From 35°C to 150°C - TBC
Sensitivity error @-40°C-35°C	<b>E</b> SCOLD	%	-2.3		2.3	From -40°C to 35°C - TBC
Sum of sensitivity and linearity error	<b>E</b> SL25	% of <i>I</i> <sub>PM</sub>	-0.7		0.7	@35°C TBC
Electrical offset voltage	UOE	mV	-5		5	U <sub>out</sub> -U <sub>Iref</sub> @ U <sub>Iref</sub> =2.5 V
Electrical offset error @35°C-150°C	<b>U</b> оЕНОТ	mV	-7	4	7	U <sub>out</sub> -U <sub>ref</sub>
Electrical offset error @-40°C-35°C	UOECOLD	mV	-6.5		6.5	Uout-Uref
Noise voltage spectral density	Uno	μV/Hz <sup>1/2</sup>				TBC
Linearity error 0 ±IPN	<b>E</b> ∟	%	-0.5		0.5	Referred to IPN
Linearity error 0 ±IP M	<b>€</b> ∟	%	-0.5		0.5	Referred to IPM
Total error at I <sub>PM</sub>	<b>€</b> tot	% of I <sub>PM</sub>	-2.4		2.4	From -40°C to 150°C

Table 17

#### Electrical data GXL AN 200-80 30000B

At  $T_A = 25$  °C,  $U_C = +3.3$  V,  $R_L = 100$  k $\Omega$ , unless otherwise noted

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary nominal current	<i>I</i> PN	Α		80		
Primary current, measuring range	<i>I</i> PM	Α	-200		200	
Nominal sensitivity	SN	mV/A		6.25		500 mV @ I <sub>PN</sub>
Sensitivity error @35°C	<b>8</b> s	%	-0.5		0.5	TBC
Sensitivity error @35°C-150°C	<b>E</b> SHOT	%	-2.1		2.1	From 35°C to 150°C - TBC
Sensitivity error @-40°C-35°C	<b>E</b> SCOLD	%	-2.3		2.3	From -40°C to 35°C - TBC
Sum of sensitivity and linearity error	<b>E</b> SL25	% of <i>I</i> <sub>PM</sub>	-0.7		0.7	@35°C TBC
Electrical offset voltage	UOE	mV	-5		5	U <sub>out</sub> -U <sub>Iref</sub> @ U <sub>Iref</sub> =2.5 V
Electrical offset error @35°C-150°C	<b>U</b> ОЕНОТ	mV	-7		7	U <sub>out</sub> -U <sub>ref</sub>
Electrical offset error @-40°C-35°C	<b>U</b> OECOLD	mV	-6.5		6.5	U <sub>out</sub> -U <sub>ref</sub>
Noise voltage spectral density	Uno	μV/Hz <sup>1/2</sup>				TBC
Linearity error 0 ±IPN	<b>E</b> ∟	%	-0.5		0.5	Referred to IPN
Linearity error 0 ±IPM	E∟	%	-0.5		0.5	Referred to IPM
Total error at IPM	$\boldsymbol{\varepsilon}_{tot}$	% of <i>I</i> <sub>РМ</sub>	-2.4		2.4	From -40°C to 150°C

Table 18



### Electrical data GXL AN 125-50 50100B

At  $T_A$  = 25 °C,  $U_C$  = +5 V,  $R_L$  = 100 k $\Omega$ , unless otherwise noted

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary nominal current	<i>I</i> <sub>PN</sub>	А		50		
Primary current, measuring range	<i>I</i> <sub>PM</sub>	Α	-125		125	
Nominal sensitivity	Sn	mV/A		16		800 mV @ IPN
Sensitivity error @35°C	<b>8</b> s	%	-0.5		0.5	TBC
Sensitivity error @35°C-150°C	<b>E</b> SHOT	%	-2.1		2.1	From 35°C to 150°C - TBC
Sensitivity error @-40°C-35°C	<b>E</b> SCOLD	%	-2.3		2.3	From -40°C to 35°C - TBC
Sum of sensitivity and linearity error	<b>€</b> SL25	% of <i>I</i> <sub>PM</sub>	-0.7		0.7	@35°C
Electrical offset voltage	UoE	mV	-5		5	U <sub>out</sub> -U <sub>Iref</sub> @ U <sub>Iref</sub> =2.5 V
Electrical offset error @35°C-150°C	<b>U</b> оЕНОТ	mV	-7		7	Uout-Uref
Electrical offset error @-40°C-35°C	<b>U</b> OECOLD	mV	-6.5		6.5	Uout-Uref
Noise voltage spectral density	Uno	μV/Hz <sup>1/2</sup>				TBC
Linearity error 0 ±IPN	٤∟	%	-0.5		0.5	Referred to IPN
Linearity error 0 ±IP M	٤∟	%	-0.5		0.5	Referred to IPM
Total error at IPM	<b>€</b> tot	% of I <sub>PM</sub>	-2.4		2.4	From -40°C to 150°C
Ratiometricity Error (sensitivity)	<b>&amp;</b> R	%		±0.5		From -40°C to 150°C
Ratiometricity Error (offset)	<b>E</b> RO	mV	-10		10	From -40°C to 150°C

Table 19

#### Electrical data GXL AN 200-80 50100B

At  $T_A$  = 25 °C,  $U_C$  = +5 V,  $R_L$  = 100 k $\Omega$ , unless otherwise noted

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary nominal current	<i>I</i> <sub>PN</sub>	Α		80		
Primary current, measuring range	<b>I</b> PM	A	-200		200	
Nominal sensitivity	Sn	mV/A		10		800 mV @ I <sub>PN</sub>
Sensitivity error @35°C	<b>8</b> s	%	-0.5		0.5	TBC
Sensitivity error @35°C-150°C	<b>E</b> SHOT	%	-2.1		2.1	From 35°C to 150°C - TBC
Sensitivity error @-40°C-35°C	<b>E</b> SCOLD	%	-2.3		2.3	From -40°C to 35°C - TBC
Sum of sensitivity and linearity error $@T_A = 25 \text{ °C}$	<b>€</b> SL25	% of <i>I</i> <sub>РМ</sub>	-0.7		0.7	TBC
Electrical offset voltage	UOE	mV	-5		5	U <sub>out</sub> -U <sub>lref</sub> @ U <sub>lref</sub> =2.5 V
Electrical offset error @35°C-150°C	<b>U</b> оЕНОТ	mV	-7		7	U <sub>out</sub> -U <sub>ref</sub>
Electrical offset error @-40°C-35°C	UOECOLD	mV	-6.5		6.5	U <sub>out</sub> -U <sub>ref</sub>
Noise voltage spectral density	Uno	μV/Hz <sup>1/2</sup>				TBC
Linearity error 0 ±IPN	<b>ε</b> ∟	%	-0.5		0.5	Referred to IPN
Linearity error 0 ±IPM	<b>E</b> ∟	%	-0.5		0.5	Referred to IPM
Total error at IPM	<b>€</b> tot	% of <i>I</i> РМ	-2.4		2.4	From -40°C to 150°C
Ratiometricity Error (sensitivity)	<b>€</b> R	%		±0.5		From -40°C to 150°C
Ratiometricity Error (offset)	<b>€</b> RO	mV	-10		10	From -40°C to 150°C

Table 20



#### Electrical data GXL AN 125-50 30100B

At  $T_A$  = 25 °C,  $U_C$  = +3.3 V,  $R_L$  = 100 k $\Omega$ , unless otherwise noted

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary nominal current	<i>I</i> <sub>PN</sub>	Α		50		
Primary current, measuring range	<i>I</i> <sub>PM</sub>	А	-125		125	
Nominal sensitivity	SN	mV/A		10		500 mV @ IPN
Sensitivity error @35°C	<b>&amp;</b> S	%	-0.5		0.5	TBC
Sensitivity error @35°C-150°C	<b>E</b> SHOT	%	-2.1		2.1	From 35°C to 150°C - TBC
Sensitivity error @-40°C-35°C	<b>E</b> SCOLD	%	-2.3		2.3	From -40°C to 35°C - TBC
Sum of sensitivity and linearity error @ $\tau_A$ = 25 °C	<b>€</b> SL25	% of I <sub>PM</sub>	-0.7		0.7	TBC
Electrical offset voltage	UOE	mV	-5		5	Uout-Ulref @ Ulref =2.5 V
Electrical offset error @35°C-150°C	<b>U</b> оЕНОТ	mV	-7		7	U <sub>out</sub> -U <sub>ref</sub>
Electrical offset error @-40°C-35°C	UOECOLD	mV	-6.5		6.5	U <sub>out</sub> -U <sub>ref</sub>
Noise voltage spectral density	Uno	$\mu$ V/Hz <sup>1/2</sup>				TBC
Linearity error 0 ±IPN	<b>£</b> ∟	%	-0.5		0.5	Referred to IPN
Linearity error 0 ±IPM	<b>ε</b> ∟	%	-0.5		0.5	Referred to IPM
Total error at IPM	<b>€</b> tot	% of I <sub>PM</sub>	-2.4		2.4	From -40°C to 150°C
Ratiometricity Error (sensitivity)	<b>€</b> R	%		±0.5		From -40°C to 150°C
Ratiometricity Error (offset)	<b>€</b> RO	mV	-10		10	From -40°C to 150°C

Table 21

### Electrical data GXL AN 200-80 30100B

At  $T_A$  = 25 °C,  $U_C$  = +3.3 V,  $R_L$  = 100 k $\Omega$ , unless otherwise noted

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Primary nominal current	<i>I</i> <sub>PN</sub>	Α		80		
Primary current, measuring range	<b>I</b> PM	A	-200		200	
Nominal sensitivity	Sn	mV/A		6.25		500 mV @ <i>I</i> PN
Sensitivity error @35°C	<b>8</b> s	%	-0.5		0.5	TBC
Sensitivity error @35°C-150°C	<b>E</b> SHOT	%	-2.1		2.1	From 35°C to 150°C - TBC
Sensitivity error @-40°C-35°C	<b>E</b> SCOLD	%	-2.3		2.3	From -40°C to 35°C - TBC
Sum of sensitivity and linearity error $@T_A = 25 \text{ °C}$	<b>€</b> SL25	% of <i>I</i> <sub>РМ</sub>	-0.7		0.7	TBC
Electrical offset voltage	UOE	mV	-5		5	U <sub>out</sub> -U <sub>lref</sub> @ U <sub>lref</sub> =2.5 V
Electrical offset error @35°C-150°C	<b>U</b> оЕНОТ	mV	-7		7	U <sub>out</sub> -U <sub>ref</sub>
Electrical offset error @-40°C-35°C	UOECOLD	mV	-6.5		6.5	U <sub>out</sub> -U <sub>ref</sub>
Noise voltage spectral density	Uno	μV/Hz <sup>1/2</sup>				TBC
Linearity error 0 ±IPN	<b>ε</b> ∟	%	-0.5		0.5	Referred to IPN
Linearity error 0 ±IPM	<b>E</b> ∟	%	-0.5		0.5	Referred to I <sub>PM</sub>
Total error at IPM	<b>€</b> tot	% of <i>I</i> РМ	-2.4		2.4	From -40°C to 150°C
Ratiometricity Error (sensitivity)	<b>€</b> R	%		±0.5		From -40°C to 150°C
Ratiometricity Error (offset)	<b>€</b> RO	mV	-10		10	From -40°C to 150°C

Table 22

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### **Overcurrent detection (OCD)**

Overcurrent detection is a feature included on GXL AN product to detect high peaks of currents happening during operation. Two overcurrent detection types are included in this product:

Internal OCD which offers the fastest reaction time and External OCD with a user settable threshold.

### Internal overcurrent detection (OCD\_INT pin)

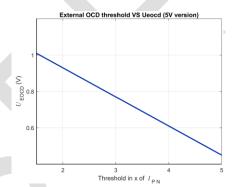
Parameter	Symbol	Unit	Min	Тур	Max	Comment
OCD_INT detection threshold	/I OCD Th	А		3 x ± <i>l</i> ⊳ n		1.5 to 5 x ±l <sub>PN</sub> available. Contact LEM for more options
OCD_INT threshold error	€ I OCD Th	%		±9		<i>U</i> <sub>c</sub> = 5V
OCD_INT threshold error	€ I OCD Th	%		±15		<i>U</i> <sub>c</sub> = 3.3∨
OCD_INT output on resistance to GND	Ronlocd	Ω		11	46	Open drain output, active low
OCD_INT output on sink capability	I <sub>I</sub> OCDmax	mA	16	20		
OCD_INT output hold time	<i>t</i> hold I OCD	μS	8	10	12	
OCD_INT delay time	t <sub>d i ocd</sub>	μS			0.5	

Table 23

### External overcurrent detection (OCD\_EXT pin)

Parameter	Symbol	Unit	Min	Тур	Max	Comment
OCD_EXT threshold error	<b>ε</b> E OCD Th	% of Full Scale		±6.8		<i>U</i> <sub>c</sub> = 5V, bipolar
OCD_EXT threshold error	<b>ε</b> E OCD Th	% of Full Scale		±14		<i>U</i> <sub>c</sub> = 3.3V, bipolar
OCD_EXT output on resistance to GND	Ron E OCD	Ω		11	46	Open drain output, active low
OCD_EXT output on sink capability	I <sub>E OCDmax</sub>	mA	16	20		
OCD_EXT output hold time	thold E OCD	μS	2.5		10	
OCD_EXT delay time	<b>t</b> D E OCD	μS		1.5	2	

Table 24



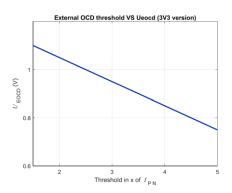


Figure 3 & 4: OCD level threshold for 5V and 3.3V versions

### **Overcurrent Detection (OCD) Equations**

$$U_{\text{E OCD}} = \frac{R_{\text{E}}}{R_{\text{E}} + R_{\text{ref}}} * U_{\text{Source}}$$

Eqn1. External OCD Voltage

$$I_{\text{THRESHOLD}} = -6.5 * \left(\frac{R_{\text{E}}}{R_{\text{E}} + R_{\text{ref}}} * U_{\text{Source}}\right) + 7.8125$$

Eqn2. External OCD Current Threshold (in x of lpn) - 5V versions



$$I_{\text{THRESHOLD}} = -10 * \left(\frac{R_{\text{E}}}{R_{\text{E}} + R_{\text{ref}}} * U_{\text{Source}}\right) + 12.5$$

Eqn3. External OCD Current Threshold (in x of lpn) - 3.3V versions

### Thermal characteristics

When designing a system containing a current sensor, self-heating due to the flow of the current should be considered. When a current pass through, the sensor's temperature will increase, and this may affect its performances. This change on temperature will depend on the current profile, PCB layout, cooling techniques and copper thickness. The following plots show an example of different thermal responses of the GXL AN sensor when used on an evaluation LEM board.

**Error! Reference source not found.** shows the continuous RMS current that GXM/L AN is capable of measuring d epending on the maximum expected temperature of the system.

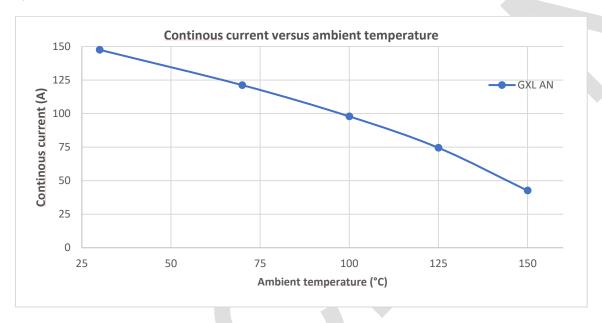


Figure 8 Measuring range vs temperature

Finally, Figure represents the maximum measurement range (peak current) versus the temperature.

The maximum temperature should be evaluated on the final system where the current sensor is integrated on the real application. This temperature should never exceed the maximum junction temperature as shown on the previous paragraphs.





# **Evaluation board PCB**

All the above results will be based on a LEM evaluation board.

Details on the evaluation board: to be added soon





# **Recommended application schematics**

### **Typical schematics GXL AN**

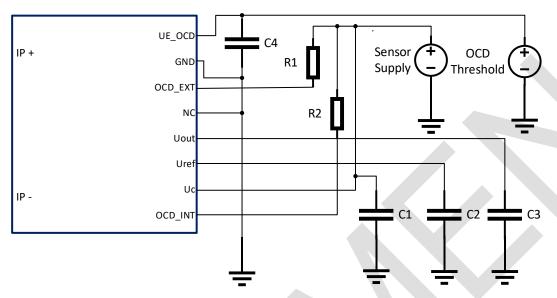


Figure 10: Typical application schematics; AN products

Output measurement is performed using Uout and Uref, both OCD are used.

Reference	Value	Comments
C1	47nF	Decoupling capacitor. To be placed as close as possible to the sensor.
C2	4.7nF	Reference capacitor, mandatory if internal reference voltage is used.
		Depending on the application, this value can be increased to 47nF to
		improve the stability. To be placed as close as possible to the sensor.
C3	4.7nF	Output capacitor. Insure stable output operation on full bandwidth. To be
		placed as close as possible to the sensor.
C4	4.7nF	Only mounted if OCD_EXT functionality is used. This capacitor insure a
		better immunity of Ue OCD to noise and transients. OCD_EXT accuracy
		cannot be guaranteed if not mounted. To be placed as close as possible to
		the sensor.
R1	10kOhms	OCD Pull up. Must be connected to Uc, as close as possible to the sensor.
R2	10kOhms	OCD Pull up. Must be connected to Uc, as close as possible to the sensor.
Supply	5V / 3.3V	Supply voltage matching product requirements.
OCD	See datasheet	OCD threshold voltage source must be very stable to insure an accurate
threshold		threshold.
voltage		Different methods can be used to fix the OCD threshold:
		- External source (DAC, amplifier, Zener diode)
		<ul> <li>Resistor divider, connected to Uc or Uref</li> </ul>
		See "External OCD" chapter for more details.

Table 1: Typical recommended components (AN products)

For more details, please read "ICS Products Schematics" application note available on LEM website.



### **Terms and definitions**

# Definition of typical, minimum and maximum values

Minimum and maximum values for specified limiting and safety conditions have to be understood as such as well as values shown in "typical" graphs.

On the other hand, measured values are part of a statistical distribution that can be specified by an interval with upper and lower limits and a probability for measured values to lie within this interval.

Unless otherwise stated (e.g. "100 % tested"), the LEM definition for such intervals designated with "min" and "max" is that the probability for values of samples to lie in this interval is 99.73 %.

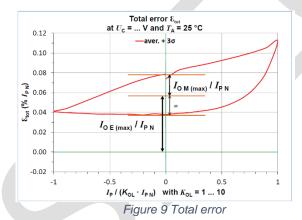
For a normal (Gaussian) distribution, this corresponds to an interval between -3 sigma and +3 sigma. If "typical" values are not obviously mean or average values, those values are defined to delimit intervals with a probability of 68.27 %, corresponding to an interval between -sigma and +sigma for a normal distribution.

Typical, maximal and minimal values are determined during the initial characterization of the product.

### **Total error referred to primary**

The total error  $\mathcal{E}_{tot}$  is the error at  $\pm I_{PN}$ , relative to the FS (Full Scale). It includes all errors mentioned below:

- the electrical offset IOE
- the magnetic offset IO M
- the sensitivity error εs
- the linearity error  $\mathcal{E}_L$  (to  $I_{PN}$ )



### **Electrical offset referred to primary**

Using the current cycle shown in figure 7, the electrical offset current  $lo_E$  is the residual output referred to primary when the input current is zero.

### Magnetic offset referred to primary

$$I_{\text{OE}} = \frac{I_{P(3)} + I_{P(5)}}{2}$$

$$I_{\text{OM}} = \frac{I_{\text{P}(3)} - I_{\text{P}(5)}}{2}$$

The magnetic offset current  $I_{OM}$  is the consequence of a current on the primary side ("memory effect" of the transducer's ferro-magnetic core). It is measured using the following primary current cycle.  $I_{OM}$  depends on the current value  $I_P \ge I_{PN}$ .

Kol: Overload factor

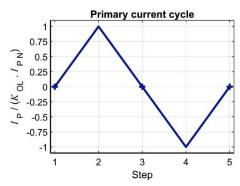


Figure 10 Current cycle used to measure magnetic and electrical offset (transducer supplied)

### **Sensitivity and linearity**

To measure sensitivity and linearity, the primary current (DC) is cycled from 0 to  $I_P$ , then to  $-I_P$  and back to 0 (equally spaced  $I_{PN}/10$  steps). The sensitivity S is defined as the slope of the linear regression line for a cycle between  $\pm I_{PN}$ .

The linearity error  $\mathbf{E}_L$  is the maximum positive or negative difference between the measured points and the linear regression line, expressed in % of  $I_{PN}$ .

#### **Delay times**

The delay time  $t_{D\ 10}$  @ 10 % and the delay time  $t_{D\ 90}$  @ 90 % with respect to the primary are shown in the next figure.

Both slightly depend on the primary current di/dt. They are measured at nominal current.

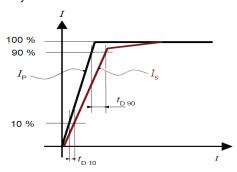


Figure 11 Delay times

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# **PCB** footprint (in mm)

### **GXL** solder pads layout:

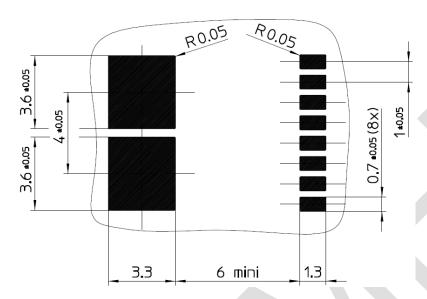
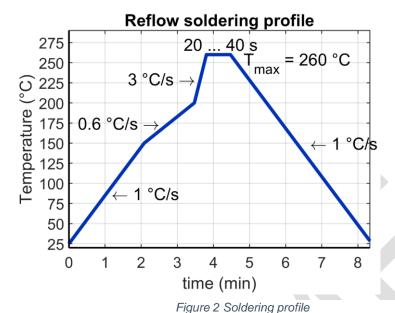


Figure 12 GXL PCB footprint



# **Soldering on PCB**



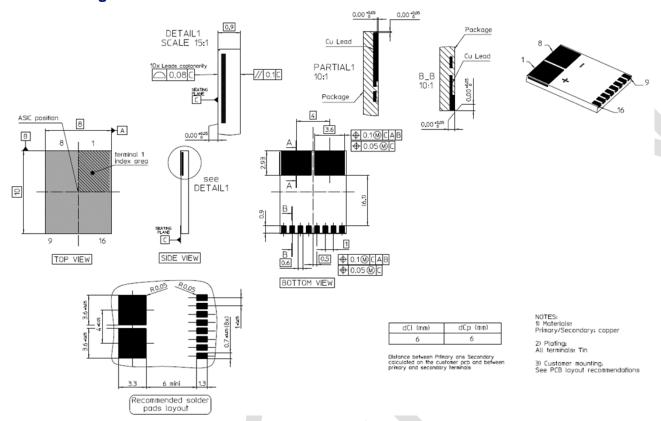
#### Soldering remarks:

- GXL is targeted to be qualified MSL3 for storage and mounting purposes.
- Per JEDEC J-STD-020E for packages less than 1.6 mm thick per table 4.2 (Pb-Free Process) of the specification.
- Best practice is to use 7 zones or greater conventional reflow system, limiting the time at reflow temperature as indicated in profile above.
- Rework not recommended.



# **Dimensions (in mm)**

### **GXL** drawings:



Mechanical characteristics: General tolerance ±0.15 mm

**Remark:**  $U_{\text{out}} - U_{\text{ref}}$  is positive when  $I_{\text{P}}$  flows in the direction of arrow (pin 1 to pin 8).



# Tape and Reel (in mm)

to be added soon







### **Safety**



#### Caution

This transducer must be used in electric/electronic equipment with respect to applicable standards and safety requirements in accordance with the manufacturer's operating instructions.

Caution, risk of electrical shock



This transducer must be used in limited-energy secondary circuits according to IEC 62368-1.

When operating the transducer, certain parts of the module can carry hazardous voltages and high currents (e.g. power supply, primary conductor). Ignoring this warning can lead to injury and or/or cause serious damage.

This transducer is a build-in device, whose hazardous live parts must be inaccessible after installation. A protective enclosure or additional shield could be used. Main supply must be able to be disconnected.

Although LEM applies utmost care to facilitate compliance of end products with applicable regulations during LEM product design, use of this part may need additional measures on the application side for compliance with regulations regarding EMC and protection against electric shock. Therefore, LEM cannot be held liable for any potential hazards, damages, injuries or loss of life resulting from the use of this product.

ESD susceptibility



This product is susceptible to be damaged from an ESD event and the personnel and workspace should be grounded when handling it.



# **Revision history**

Version	Date	Description
0.1	15 <sup>th</sup> of February 2024	Initial Release – target datasheet
0.4	27 <sup>th</sup> of September 2024	8 products listed, performance update based on measurements, minor
		cosmetics improvements.

